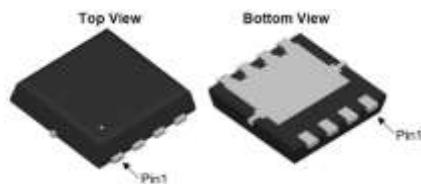


-20V_{DS}/±12V_{GS} P-Channel Enhancement Mode MOSFET

Features

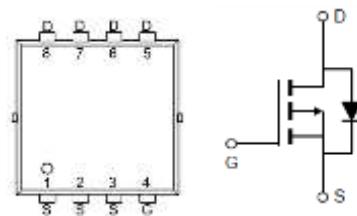
- $V_{DS}=-20V, I_D=-85A$
- $R_{DS(ON)}=3m\Omega$ (TYP.) $V_{GS}=-4.5V$
- Reliable and Rugged
- Avalanche Rated
- Low On-Resistance

PDFN5060



Applications

- Portable device
- Switch switching
- Load Switch
- Power management in portable/desktop PCs
- DC/DC conversion



Ordering Information

Device	package	Device Marking	Package Qty.
HM20P85D5	PDFN5060	**	5000/PCS

Absolute Maximum Ratings ($T_C=25^\circ C$,unless otherwise noted)

Parameter	Symbol	Value	Unit
Drain-Source Voltage ($V_{GS}=0V$)	V_{DS}	-20	V
Gate-Source Voltage ($V_{GS}=0V$,static)	V_{GS}	±12	V
Continuous Drain Current ($T_C=25^\circ C$)	I_D	-85	A
Continuous Drain Current ($T_C=100^\circ C$)		-55	A
Pulsed Drain Current	I_{DM}	-340	A
Avalanche Energy, Single Pulsed	E_{AS}	154	mJ
Maximum Power Dissipation ($T_C=25^\circ C$)	P_D	33	W
Operating,Storage Temperature Range	T_J, T_{STG}	-55~150	°C

Electrical Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=-250\mu A$	-20	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=-30V, V_{GS}=0V$	-	-	-1	μA
Gate -Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-0.4	--	-1.0	V
Drain-Source On-stage Resistance	$R_{DS(ON)}$	$V_{GS}=-4.5V, I_D=-1A$	-	-	3.0	$m\Omega$
		$V_{GS}=-2.5V, I_D=-1A$	-	-	5	

Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance,Junction-to-Case	R _{θJC}	-	3.8	-	°C/ W
Thermal Resistance,Junction-to-Ambient	R _{θJA}	-	-	-	°C/ W

Dynamic Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Input capacitance	C _{iss}	V _{DS} =-15V V _{GS} =0V f=1MHz	-	1500	-	pF
Output capacitance	C _{oss}		-	1000	-	
Reverse transfer capacitance	C _{rss}		-	-	-	
Gate Resistance	R _g	f=1MHz	-	-	-	Ω
Total Gate Charge	Q _g	V _{DS} =-15V V _{GS} =-10V I _D =-15A	-	100	-	nC
Gate Source Charge	Q _{gs}		-	21	-	
Gate Drain Charge	Q _{gd}		-	32	-	
Turn-on delay Time	t _{d(on)}	V _{GS} =-10V V _{DS} =-15V R _L =1Ω R _G =3Ω	-	50	-	ns
Rise time	t _r		-	100	-	
Turn-off delay Time	t _{d(off)}		-	40	-	
Fall time	t _f		-	-	-	

Reverse Diode Characteristics

Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Body Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _{SD} =-1A	-	-	-1.2	V
Reverse Recovery Time	t _{rr}	V _{GS} =0V, I _{SD} =-15A d/dt=100A/μs	-	-	-	ns
Reverse Recovery Charge	Q _{rr}		-	-	-	nC

Electrical Characteristics Diagrams

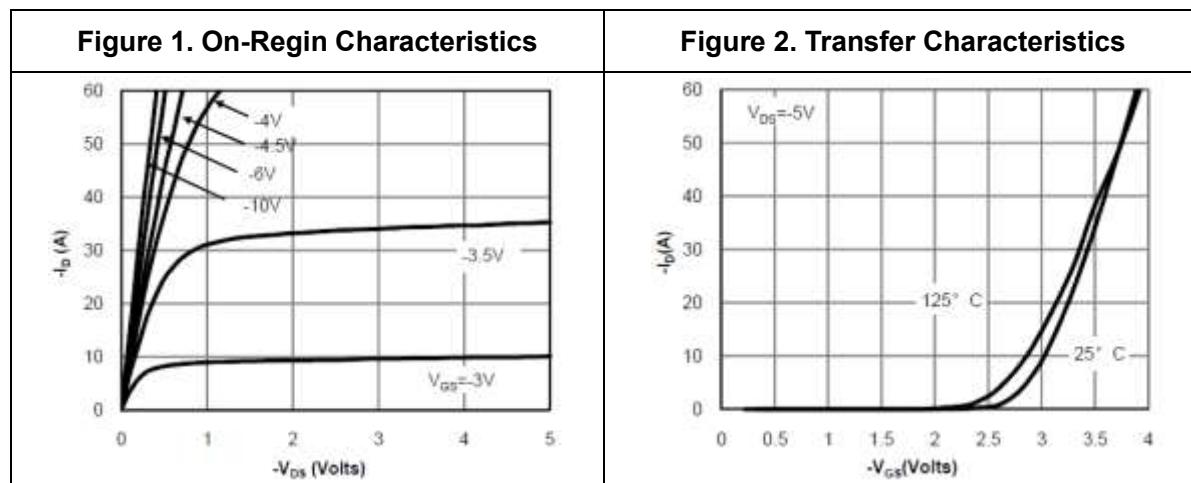


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

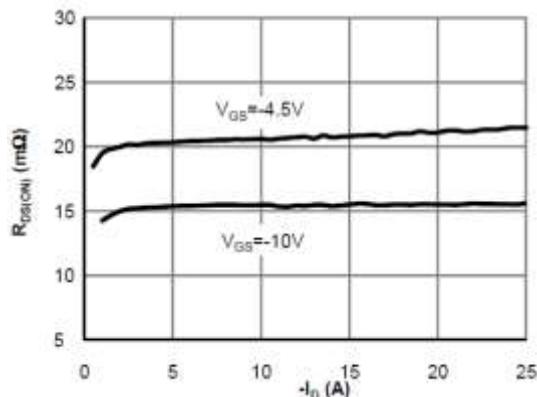


Figure 4. On-Resistance vs. Junction Temperature

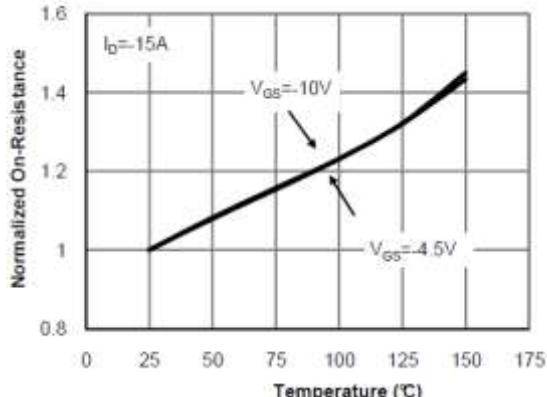


Figure 5. On-Resistance vs. Gate-Source Voltage

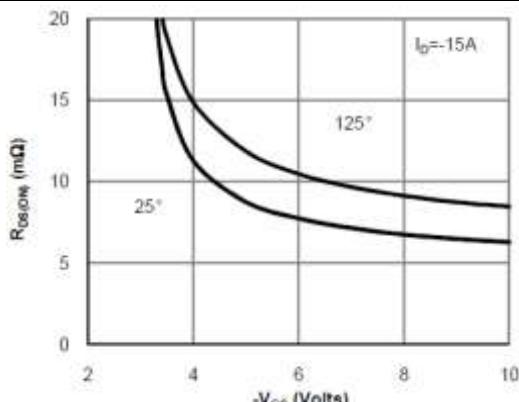


Figure 6. Body-Diode Characteristics

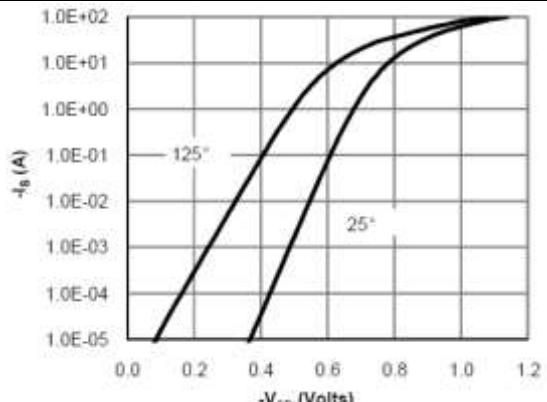


Figure 7. Gate-Charge Characteristics

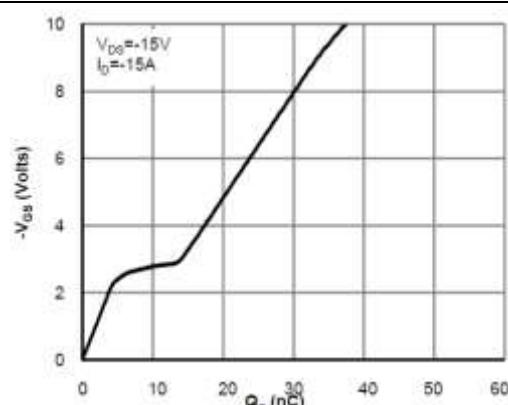


Figure 8. Capacitance Characteristics

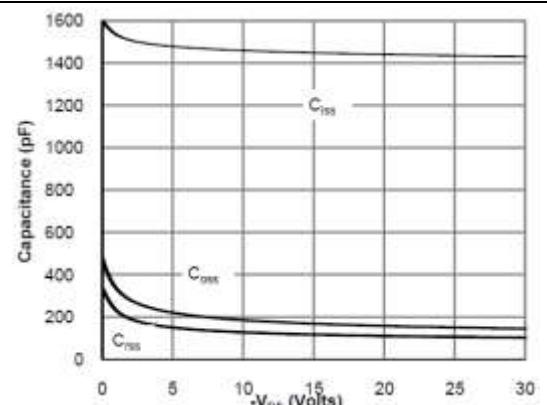


Figure 9. Maximum Forward Biased Safe Operating Area

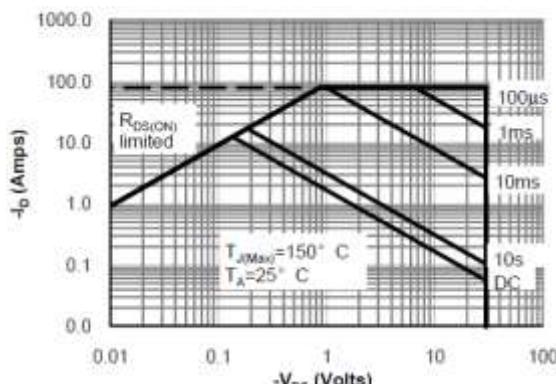


Figure 10. Single Pulse Power Rating Junction-to-Ambient

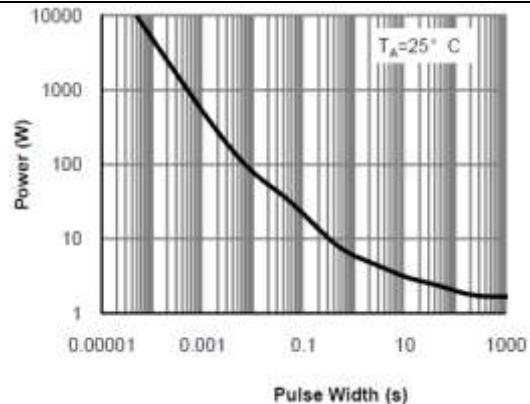
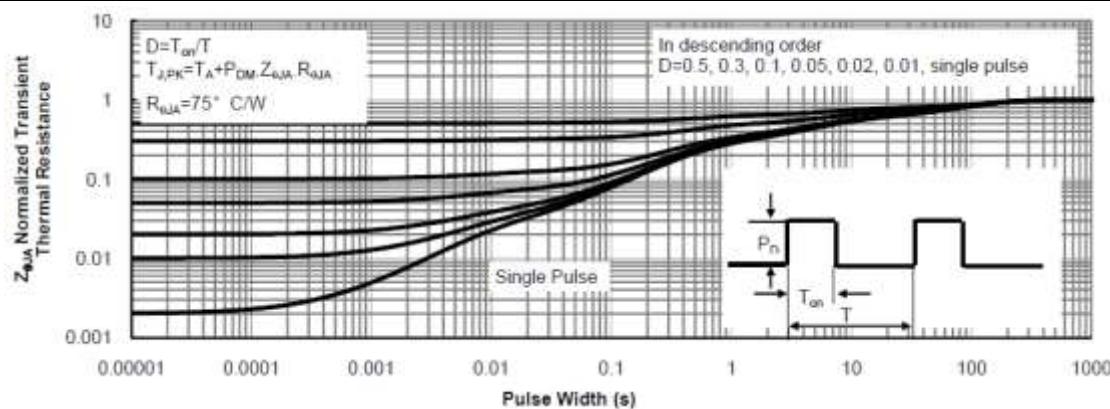


Figure 11. Normalized Maximum Transient Thermal Impedance



Physical Dimensions

PDFN5060

符号	尺寸 (mm)			符号	尺寸 (mm)		
	最小值	典型值	最大值		最小值	典型值	最大值
A	0.90	1.00	1.10	E1	5.70	5.75	5.80
b	0.33	0.41	0.51	E2	3.38	3.58	3.78
c	0.20	0.25	0.30	H	0.41	0.51	0.61
D	4.80	4.90	5.00	K	1.10	-	-
D1	3.61	3.81	3.96	L	0.51	0.61	0.71
e	1.27BSC			L1	0.06	0.13	0.20
E	5.90	6.00	6.10	θ	0°	-	12°

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